



RF beam diagnostics 1st part

A. Mostacci

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OUTLINE

RF beam diagnostics – 1st lecture

Introduction

- Definitions (from metrology)
- Field from a relativistic moving charge

Beam intensity diagnostics

- **Current transformers**
- Passive Cavity based devices

Beam transverse position diagnostics

- Transmission line beam position monitor
- Cavity beam position monitor

Longitudinal diagnostics

Only few selected examples

- It is impossible to cover all.
- to show general principles.
- to link to the hands on session (bench measurement).



BASIC DEFINITIONS

Measurement accuracy

closeness of agreement between a **measured quantity** value and a true quantity value of a measurand

Measurement uncertainty

non-negative parameter characterizing the dispersion of the **quantity values** being attributed to a **measurand**, based on the information used.

Resolution (of the measurement system)

smallest change in a **quantity** being measured that causes a perceptible change in the corresponding **indication**

Sensitivity of a measuring system

quotient of the change in an **indication** of a **measuring system** and the corresponding change in a **value** of a **quantity** being measured.

Calibration

Hopefully once!!!

Precision

Hopefully always!!!

It depends on noise

International Vocabulary of Metrology – Basic and General Concepts and Associated Terms (VIM)

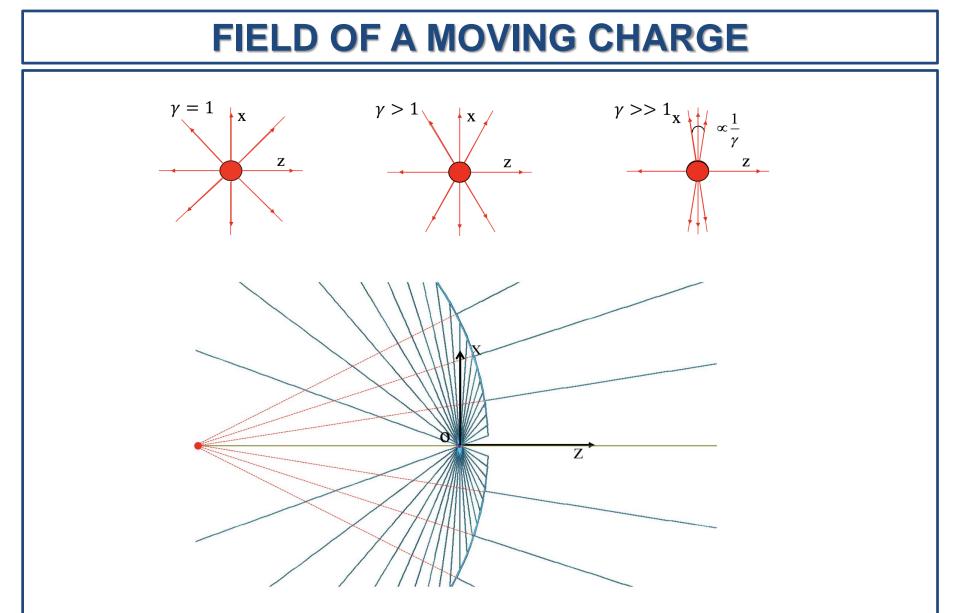


Organisation Internationale de Métrologie Légale

INTERNATIONAL ORGANIZATION OF LEGAL METROLOGY



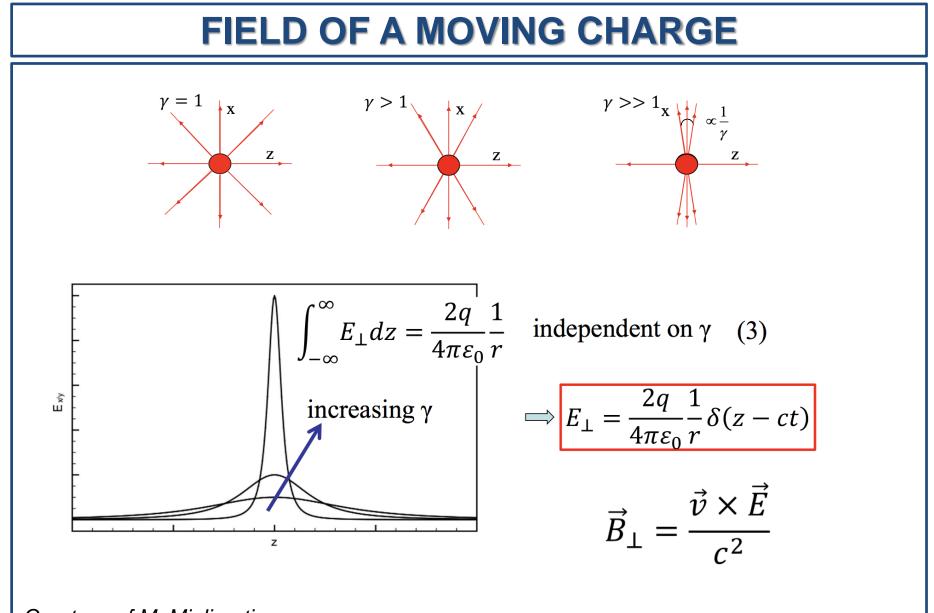
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Courtesy of M. Migliorati



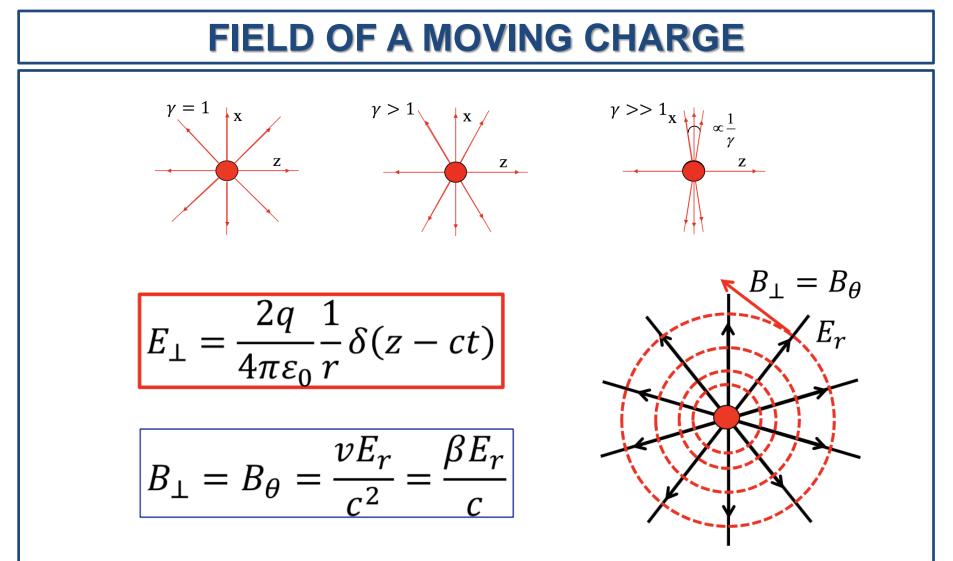
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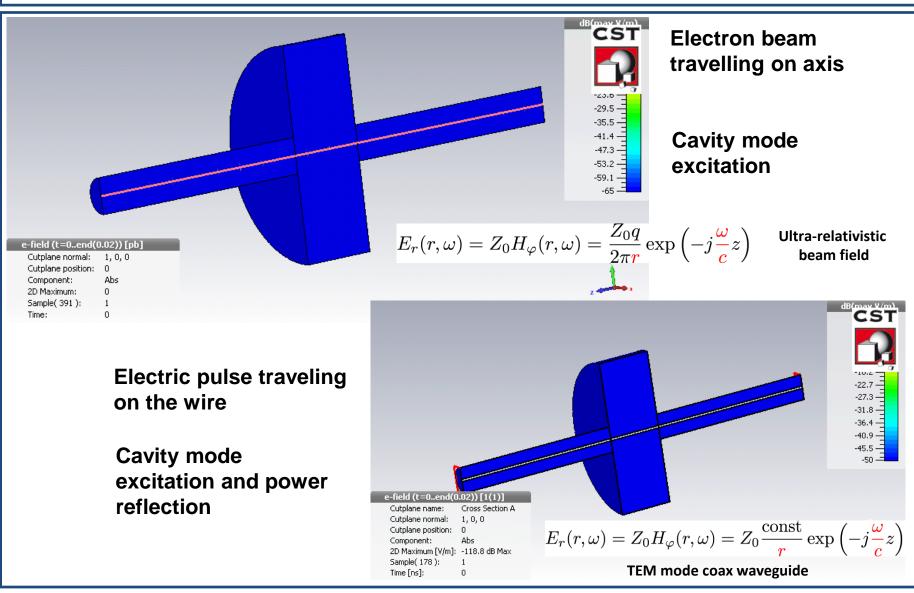
Only Transverse Electric Magnetic (TEM) field components

Courtesy of M. Migliorati



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PRIMER OF BENCH MEASUREMENTS

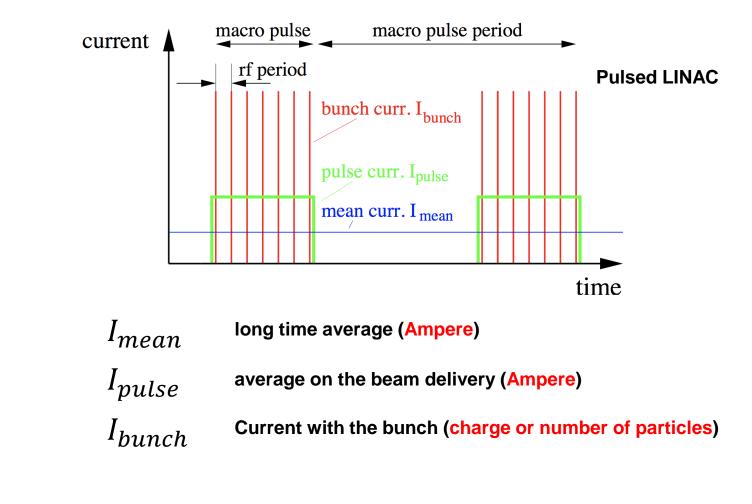


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BEAM INTENSITY

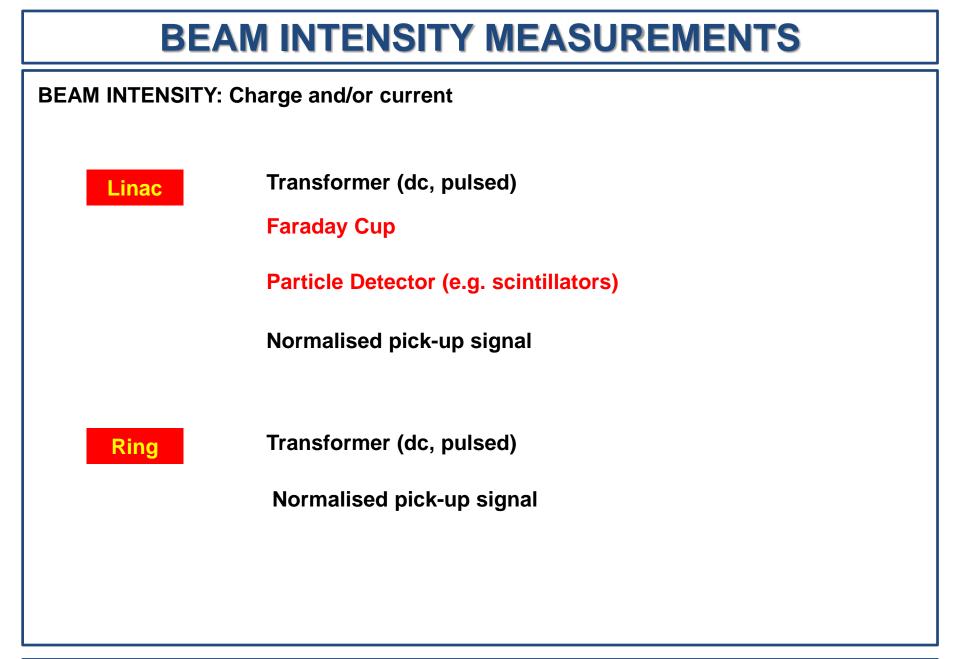
BEAM INTENSITY: Charge and/or current



Courtesy of P. Forck

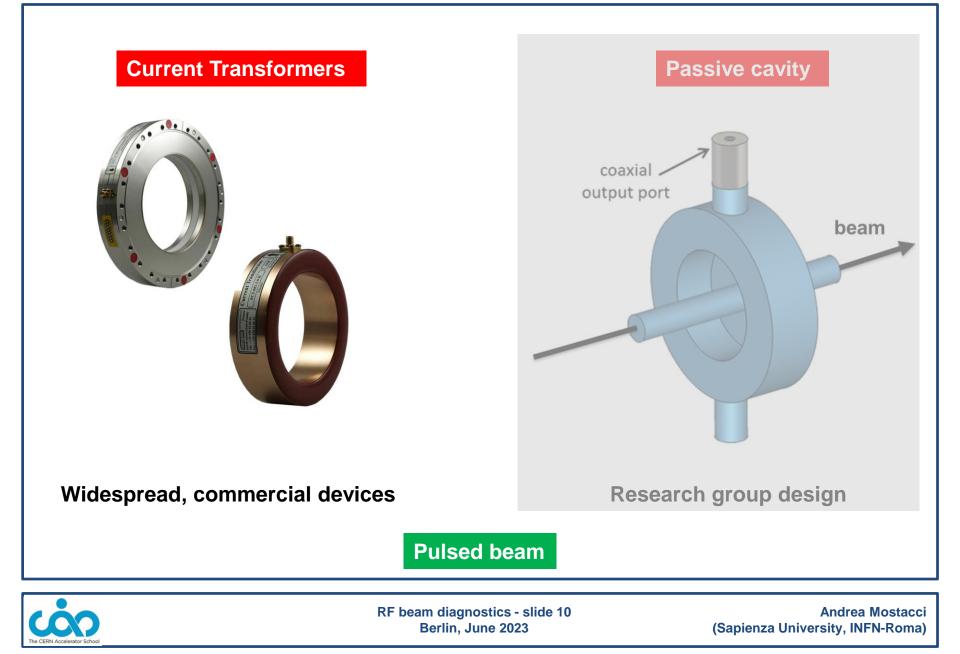


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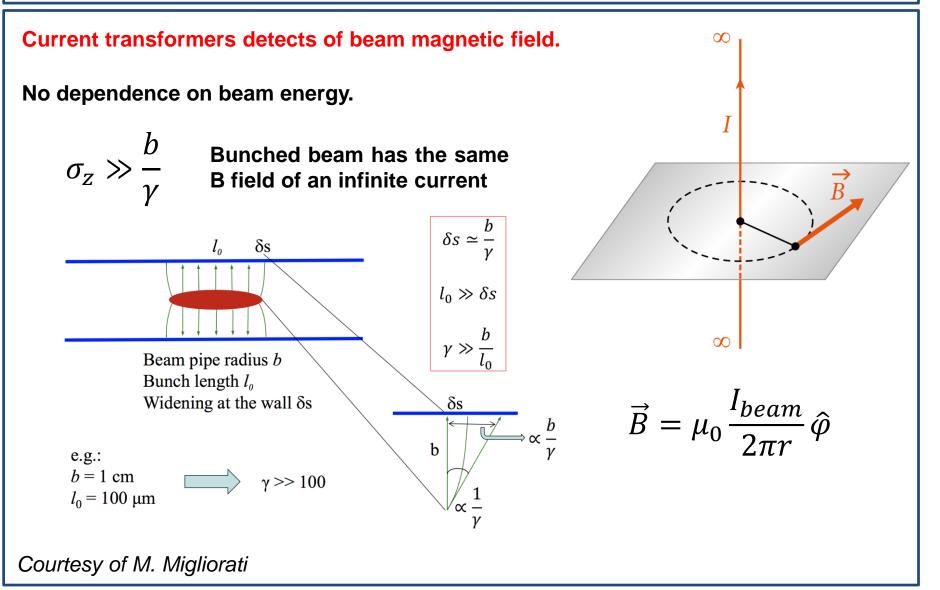




BEAM INTENSITY



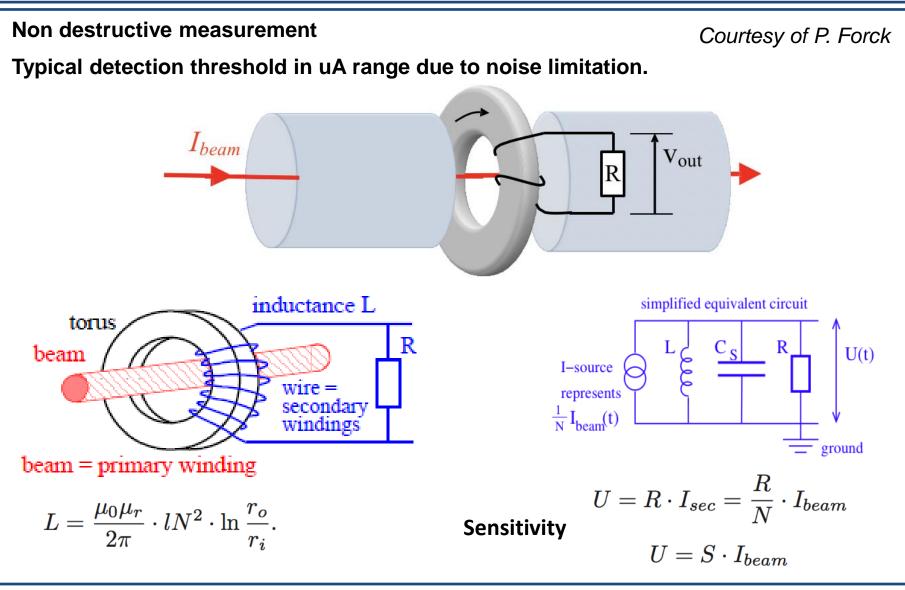
B FIELD PROPERTIES





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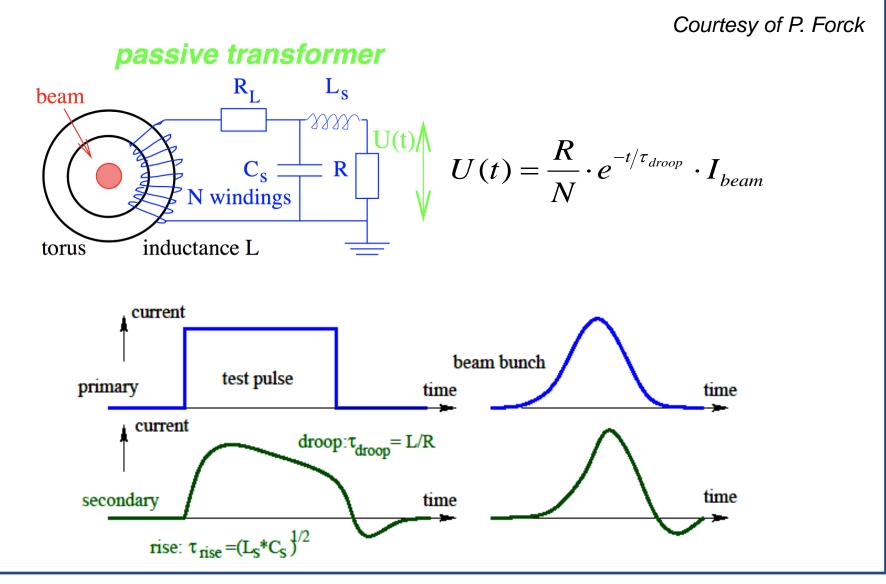
CURRENT TRANSFORMER – PULSED BEAM





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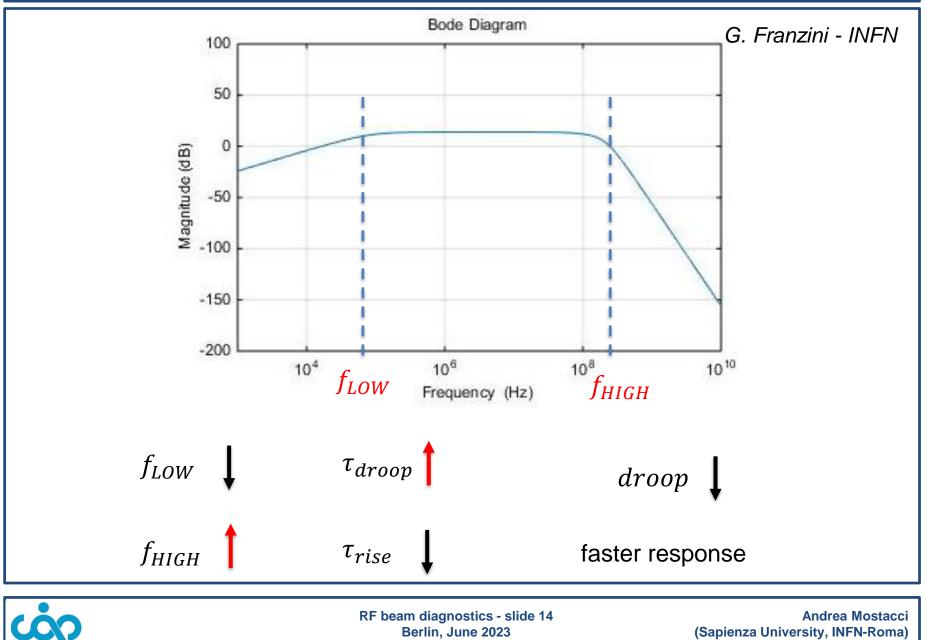
FAST CURRENT TRANSFORMER - FCT





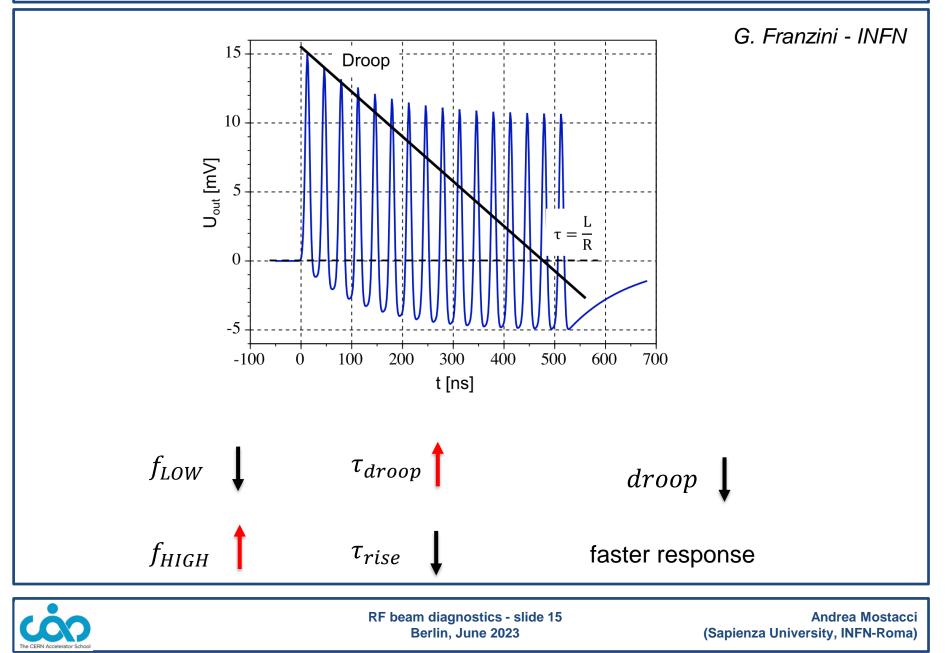
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FAST CURRENT TRANSFORMER PARAMETERS



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FAST CURRENT TRANSFORMER PARAMETERS



FCT FROM INDUSTRIAL SUPPLIER



In-flange FCT



In-air FCT

Wideband models (standard)

Sensitivity (nominal)	0.25	0.5	1.25	2.5	5.0	V/A
Turns ratio (old reference)	100:1	50:1	20:1	10:1	5:1	
Rise time (typ.)*	0.60	0.30	0.23	0.30	0.39	ns
Droop	< 1	< 3	< 6	< 10	< 32	%/µs
Upper cutoff frequency -3dB typ. *	0.58	1.17	1.50	1.17	0.90	GHz
Lower cutoff frequency -3dB typ. *	< 1.6	< 5	< 9.5	< 16	< 50	kHz
L/R time constant (min.)	100	35	17	10	5	μs
Max. charge/pulse	8100	2000	324	81	20	μC
Max. rms current (f > 10 kHz)	2.7	2.7	2.7	2.7	2.7	А
Max. peak current (pulse = 1 ns)	2	0.4	0.2	0.1	0.1	kA
For 10 V/A sensitivity specifications, please ask						

* Depends on FCT sensor dimensions and selected options

Low droop (-LD) models on option

Sensitivity (nominal)	0.25	0.5	1.25	2.5	5.0	V/A
Turns ratio (old reference)	100:1	50:1	20:1	10:1	5:1	
Rise time (typ.)*	1.00	0.54	0.40	0.50	0.78	ns
Droop	< 0.05	< 0.2	< 1	< 3	< 8	%/µs
Upper cutoff frequency -3dB typ. *	350	650	850	700	450	MHz
Lower cutoff frequency -3dB typ. *	< 0.08	< 0.32	< 1.6	< 5	< 13	kHz
L/R time constant (min.)	2000	500	100	35	12	μs
Max. charge/pulse	8100	2000	324	81	20	μC
Max. rms current (f > 10 kHz)	2.7	2.7	2.7	2.7	2.7	Α
Max. peak current (pulse = 1 ns)	2	0.4	0.2	0.1	0.1	kA
For 10 V/A sensitivity specifications, please ask						

* Depends on FCT sensor dimensions and selected options





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Andrea Mostacci (Sapienza University, INFN-Roma)

From Instrument manual

FCT main advantages

- The FCT displays the beam current with a minimum of distortion up to very high frequency. It is therefore, primarily, an instrument to be used with an oscilloscope.
- Very low ringing when it is properly installed (See: "Installation on the vacuum chamber" in this manual).

FCT limitations

- The FCT, like all transformers, differentiates the signal. When the observed pulses are longer than a few microseconds, the output droop of the FCT becomes excessive.
- The FCT has eddy current loss up to a few percent. Eddy current losses are frequency dependent, increase towards the higher frequencies. Yet, the FCT is still the best instrument to visualize a short, fast pulse on an oscilloscope when non-contact measurement is a necessity: particle beams, high voltage, etc.

FCT SPECIFICATIONS

Turns ratio / Model	20:1	5:1	20:1 –low droop	5:1 –low droop
Sensitivity (V/A)	1.25	5.0	1.25	5.0
Rise time (ns)	0.23	0.39	0.4	0.78
Droop (%/µs)	< 6	< 32	<1	< 8
Upper cutoff frequency (GHz)	1.50	0.9	0.85	0.45
Lower cutoff frequency (kHz)	< 9.5	< 50	< 1.6	< 13
L/R time constant (min.) (μs)	17	5	100	12
Max. charge/pulse (μC)	324	20	324	20
Max. rms current (A)	2.7	2.7	2.7	2.7
Max. peak current (pulse = 1 ns) (kA)	0.2	0.1	0.2	0.1

Based on the duration and shape of the bunch (i.e., its frequency content), the most suitable model can be chosen. For instance, a low risetime (i.e., high upper cut-off) may be desired to track fast variations (short bunches) at the expense of reduced sensitivity, etc.

Models with the low droop option decrease both the lower and upper cut-off frequencies. Consequently, they decrease droop but increase risetime. Therefore, they are used for longer duration bunches with slower variations.

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ACTIVE CURRENT TRANSFORMER

By using an operational amplifier in the output stage, it is possible to significantly reduce the lower cut-off compared to the FCT and, consequently, decrease the droop time.

The ACCT is therefore employed for long-duration impulses (µs-ms). Typically, an amplifier with limited bandwidth (e.g., 1 MHz) is used to reduce high-frequency noise resulting in a high risetime (e.g. 350 ns).

In-flange ACCT



In-air ACCT



ACCT ADVANTAGES COMPARED TO OTHER CTs

The ACCT can measure low AC currents accurately. Other current transformers cannot do it for the following reasons:

- A passive CT capable of passing say 50-60 Hz with less than 1% error must have a -3dB lower cutoff frequency below a few Hertz. This imposes a large number of turns, typically 500 turns. Therefore, the sensitivity is in the order of 0.1 V/A in a high impedance load.
- If 10 mA current is measured with this transformer, the output is a mere 1mV, which cannot be measured on an oscilloscope or voltmeter. The situation is not much better at 100 mA current.
- Amplifying the signal from this CT does not help much, because the noise is amplified as well.

Therefore, the ACCT is much superior to other CTs for pulses longer than tens of µs: It measures accurately down to 10 mA full scale, even down to 1 mA. It delivers a strong voltage signal, with accuracy better than 1%.

Full scale range

Lower cutoff (-3dB) Droop Upper cutoff (-3dB) Risetime

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Any value from ±1mA to ± 2A, factory preset range. <3Hz <2%/ms 1MHz 350ns (10% - 90%)

Resolution

Ranges	1mA	10mA	100mA	1A
ACCT-E-RM	<1.5µArms	<1.5µArms	<5µArms	<40µArms
ACCT-E-RM-3R	<5µArms	<5µArms	<8µArms	<25µArms
With LN option				
ACCT-E-RM	<0.5µArms	<0.5µArms	N/A	
ACCT-E-RM-3R	<1.5µArms	<1.5µArms		

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ACTIVE CURRENT TRANSFORMER

By using an operational amplifier in the output stage, it is possible to significantly reduce the lower cut-off compared to the FCT and, consequently, decrease the droop time.

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Lower cutoff (-3dB) Droop Upper cutoff (-3dB) Risetime Any value from ±1mA to ± 2A, factory preset range. <3Hz <2%/ms 1MHz 350ns (10% - 90%)

Resolution

Ranges	1mA	10mA	100mA	1A	
ACCT-E-RM	<1.5µArms	<1.5µArms	<5µArms	<40µArms	
ACCT-E-RM-3R	<5µArms	<5µArms	<8µArms	<25µArms	
With LN option					
ACCT-E-RM	<0.5µArms	<0.5µArms	NI/A		
ACCT-E-RM-3R	<1.5µArms	<1.5µArms	N/A		

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INTEGRATING CURRENT TRANSFORMER

The FCT is a pure and simple transformer that, within a certain bandwidth, allows measuring the current of the bunch while also reconstructing its temporal profile.

On the other hand, the ICT uses passive components (R, L, C) mounted on the device that completely deform the bunch profile, elongating it while guaranteeing that the integral of the output signal is proportional to the bunch charge.

It is used when the bunch is short (i.e. ps level) and FCTs would not be able to measure it. For instance in high brightness LINAC the 1ps signal from the bunch is increased up to 5ns.

ICTs are used to measure the charge of bunches when they are very short (i.e., ps level).

CTs sensitivity is in V/A, while ICTs sensitivity is given in Vs/C, emphasizing the fact that the charge of the bunch is measured by calculating the integral of the output signal.





In-air ICT





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ICT SPECIFICATIONS

Beam Charge Monitor - Integrate-Hold-Reset

Contraction of the second seco



In-air ICT

In-flange ICT

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Selectable in a range of 50:1 by TTL 800 pC, using 5 Vs/C ICT 400 nC, using 0.5 Vs/C ICT
Full scale and polarity (4 TTL bits)
0.55 pCrms, limited by dynamic range
>35'000, limited by resolution
±8 V, available 50 μs after trigger,
held for 400 μ s (up to 10 ms on option)

ICT Specifications

Sensitivity (nominal)	0.5	1.25	2.5	5.0	10.0	Vs/C
Turns ratio (old reference)	50:1	20:1	10:1	5:1	2x 5:1	
Output pulse (full length)	70	70	70	70	70	ns
Droop	< 3	< 6	< 10	< 32	< 157	%/µs
Droop with Low Droop option	< 0.2	< 1	< 3	< 8	< 32	%/µs
Max. charge/pulse	2000	324	81	20	5	μC
Max. rms current (f > 10 kHz)	2.7	2.7	2.7	2.7	2.7	А
Max. peak current (pulse = 1 ns)	0.4	0.2	0.1	0.1	0.1	kA
For 10 Vs/C sensitivity specifications, please ask						

It corresponds to a precision of 1pC

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PERFORMANCE COMPARISON

FAST CURRENT TR 10:1 2.5 V/A 16 kHz	ACTIVE CURRENT TR. (ACCT) Depends on the amplifier 3 Hz	INTEGRATING CURRENT TR. 5:1 5 Vs/C 5.3 kHz
2.5 V/A	Depends on the amplifier	5 Vs/C
16 kHz	3 Hz	5 3 kHz
		5.5 KHZ
1.17 GHz	1 MHz	191 MHz
0.3 ns	350 ns	1.5 ns
10 %/µs	2%/ms	3.6 %/µs
epends on bunch length	Depends on bunch length	5 ns
	1.5µArms (in 1A range)	~0.55 pCrms
epends on eddy currents (up to few percents)	~1%	
	0.3 ns 10 %/μs epends on bunch length pends on eddy currents	0.3 ns350 ns10 %/μs2%/msepends on bunch lengthDepends on bunch length1.5μArms (in 1A range)pends on eddy currents~1%

.. from datasheet

... measured @LNF

Datasheet parameters can vary within the same category from model to model. Therefore, they should be considered as orders of magnitude.







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ACCURACY AND RESOLUTION OF CTs

Accuracy

The accuracy can depend on several factors, including eddy currents (which, in turn, depend on the frequency content of the bunch), offset (of the measurement electronics), accuracy in device calibration/construction, and temperature.

Data on accuracy is rarely available, but when provided, it is typically presented with an order of magnitude of around 1-2% of the measured quantity (current or charge). This data has been verified against some articles.

Uncertainty

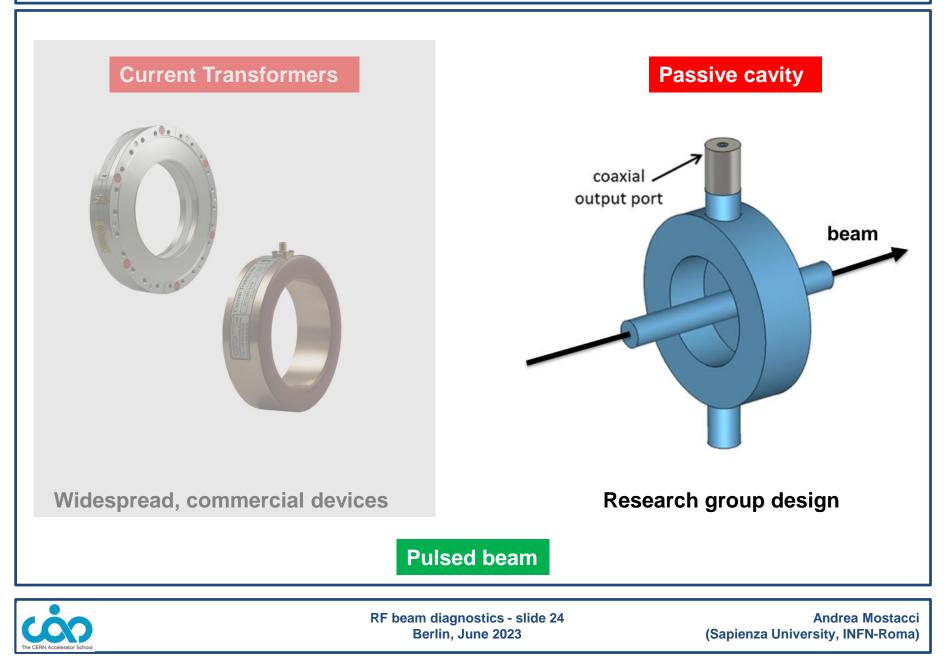
The uncertainty typically depends on the active components (such as amplifiers in the case of ACCT) and the measurement electronics. For example, in the case of SPARC high brightness LINAC, ICT uncertainty is in the order of 0.5/1 pC (measured as the rms value of noise in the measurements).

For ACCT, a value of 1.5 µArms is reported for a 1A range.

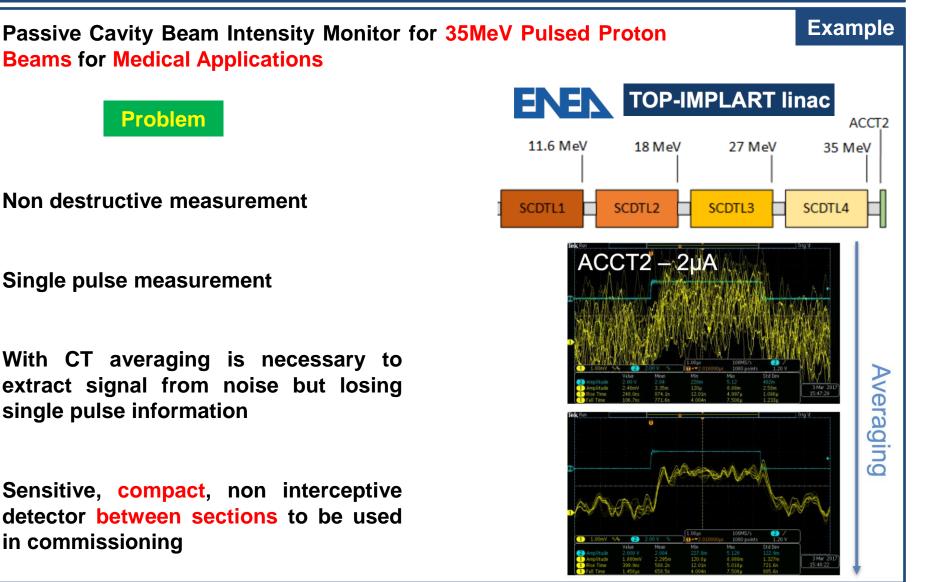
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BEAM INTENSITY



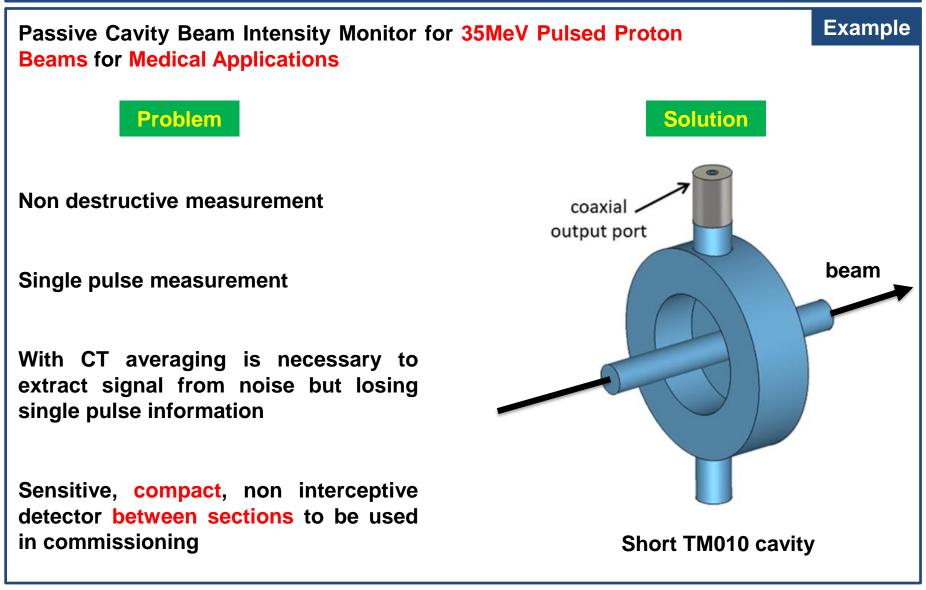
CAVITY BEAM INTENSITY MONITOR





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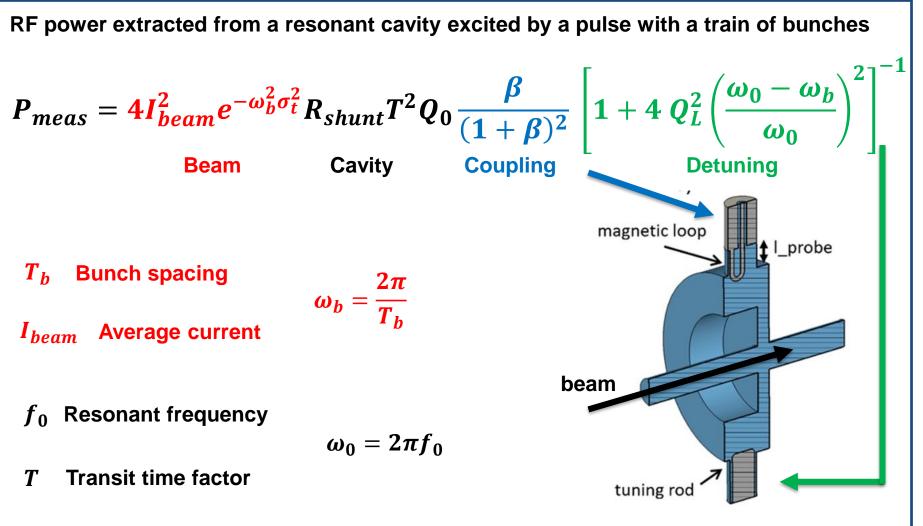
CAVITY BEAM INTENSITY MONITOR





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EXTRACTED POWER



F. Cardelli et al., **Design and test of a compact beam current monitor based on a passive RF cavity for a proton therapy linear accelerator**, Rev. Sci. Instrum. 92, 113304 (2021); https://doi.org/10.1063/5.0062509



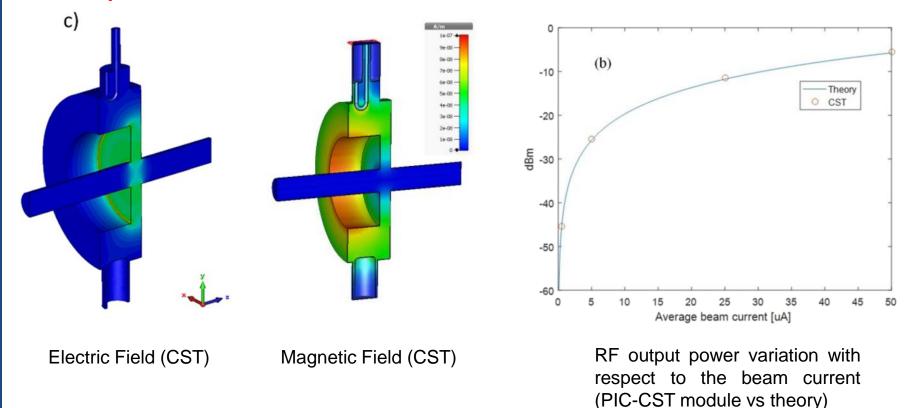
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EM DESIGN OF THE CAVITY

Design goal:

Example

re-entrant cavity 12mm long with filling time between 100 and 200 ns, maximizing shunt impedance and transit time factor



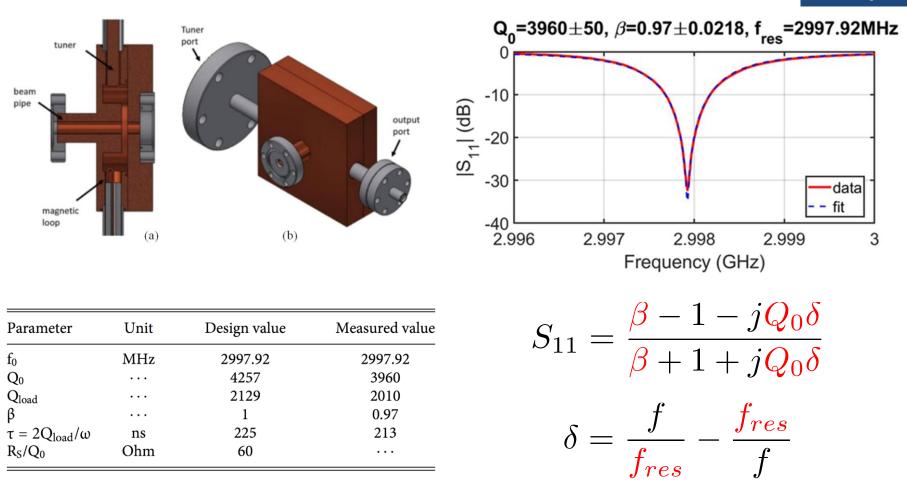
F. Cardelli et al., **Design and test of a compact beam current monitor based on a passive RF cavity for a proton therapy linear accelerator**, Rev. Sci. Instrum. 92, 113304 (2021); https://doi.org/10.1063/5.0062509



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CAVITY MEASUREMENT

Example

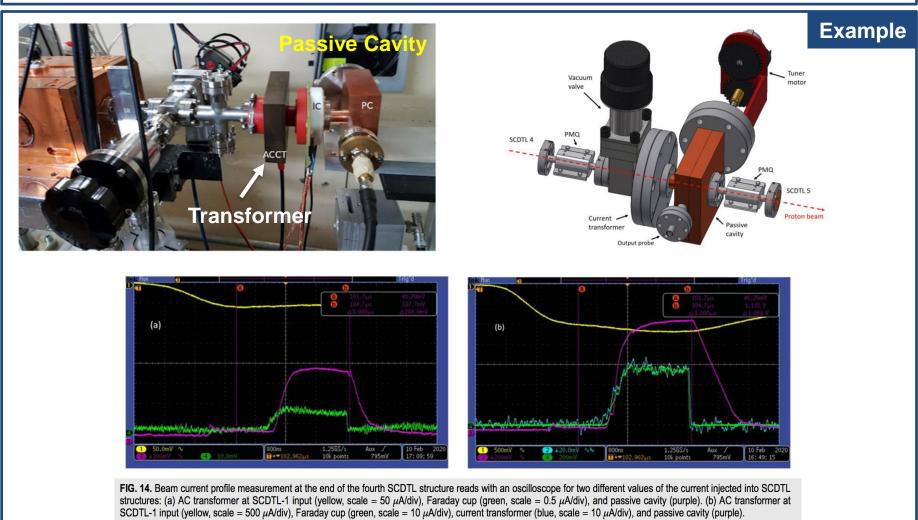


F. Cardelli et al., **Design and test of a compact beam current monitor based on a passive RF cavity for a proton therapy linear accelerator**, Rev. Sci. Instrum. 92, 113304 (2021); https://doi.org/10.1063/5.0062509



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BEAM MEASUREMENT



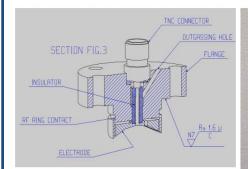
F. Cardelli et al., **Design and test of a compact beam current monitor based on a passive RF cavity for a proton therapy linear accelerator**, Rev. Sci. Instrum. 92, 113304 (2021); https://doi.org/10.1063/5.0062509



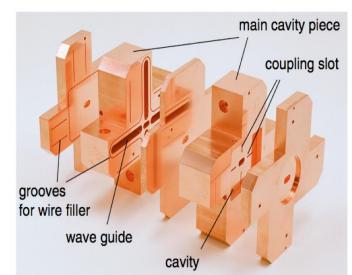
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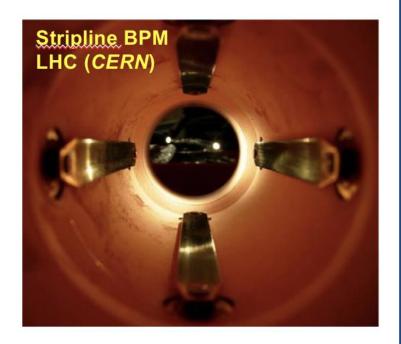
BEAM POSITION MONITOR

1



LHC Button BPM (CERN)







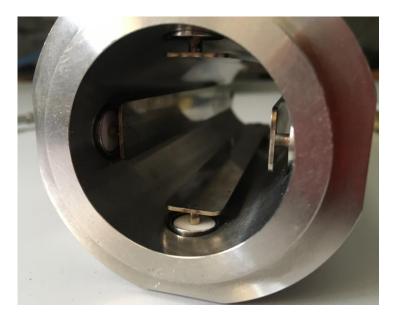
Courtesy of M. Wendt



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TRANSVERSE POSITION MEASUREMENT

Strip line BPM



Transmission line pick-up

Cavity BPM

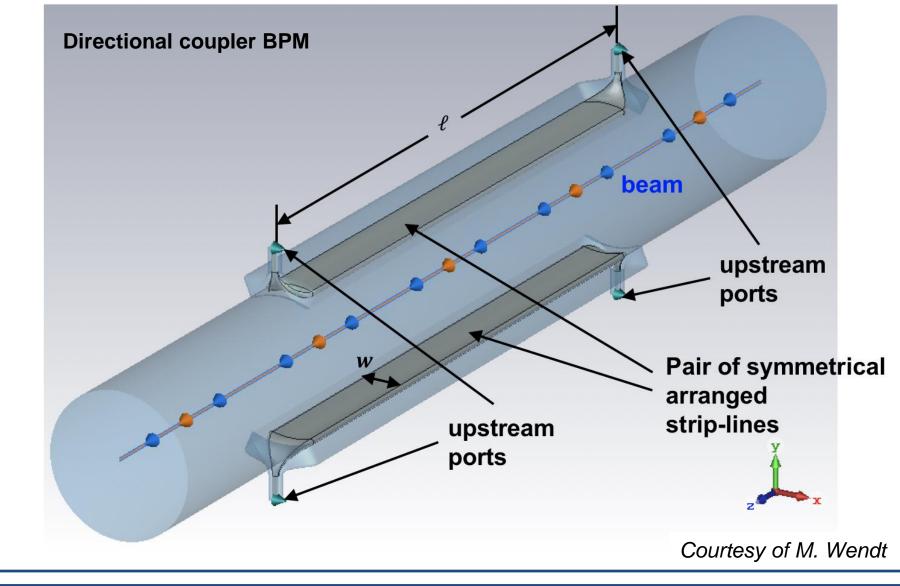


Resonant pick-up



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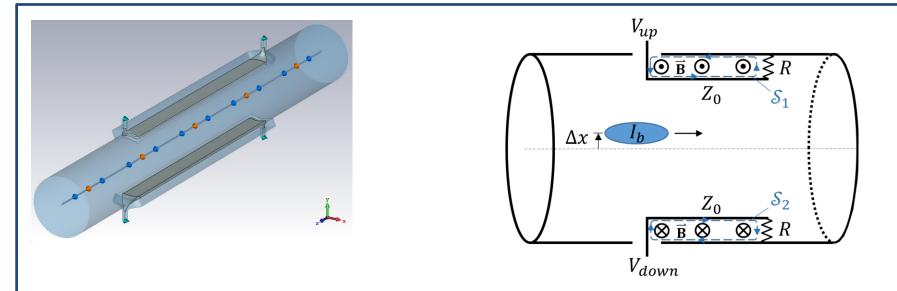
STRIPLINE BEAM POSITION MONITOR

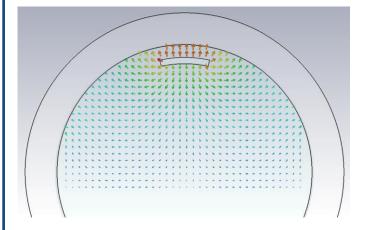




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STRIPLINE BPM BASICS





Strip transmission-line of characteristic impedance $Z_0 = 50 \Omega$

TEM signal (except near the ports)

Electric + Magnetic coupling to the beam field

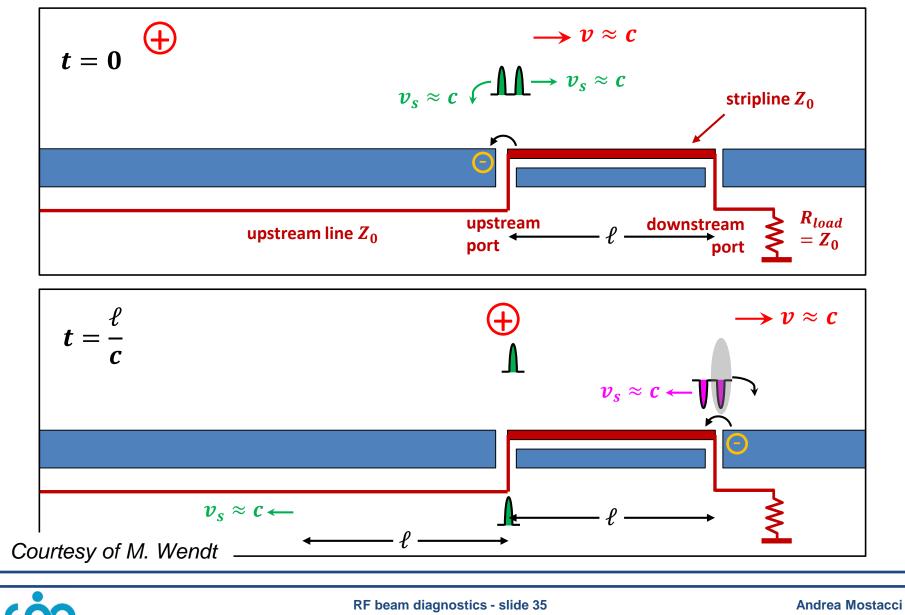
Ability of detecting beam direction

Courtesy of M. Wendt



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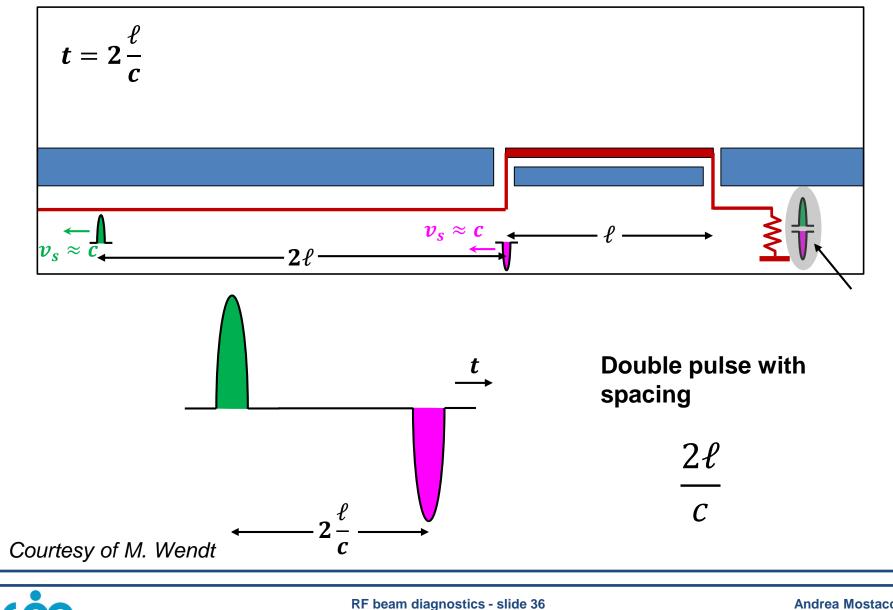
STRIPLINE BPM PRINCIPLE



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STRIPLINE BPM PRINCIPLE



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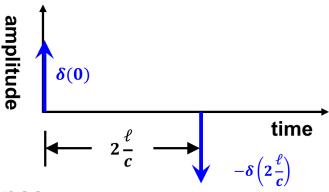
TRANSFER IMPEDANCE

• Time domain impulse response: δ-doublet pulse

characteristic impedance typically 50 Ω

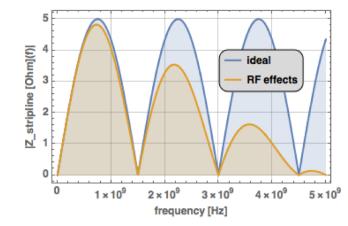
$$z(t) = \phi \frac{Z_0}{2} \left[\delta(t) - \delta \left(t - 2 \frac{\ell}{c} \right) \right]$$

coverage factor



• Frequency domain transfer impedance

$$Z_0 = 50\Omega, \ell = 100 \ mm, \phi = 0.1$$



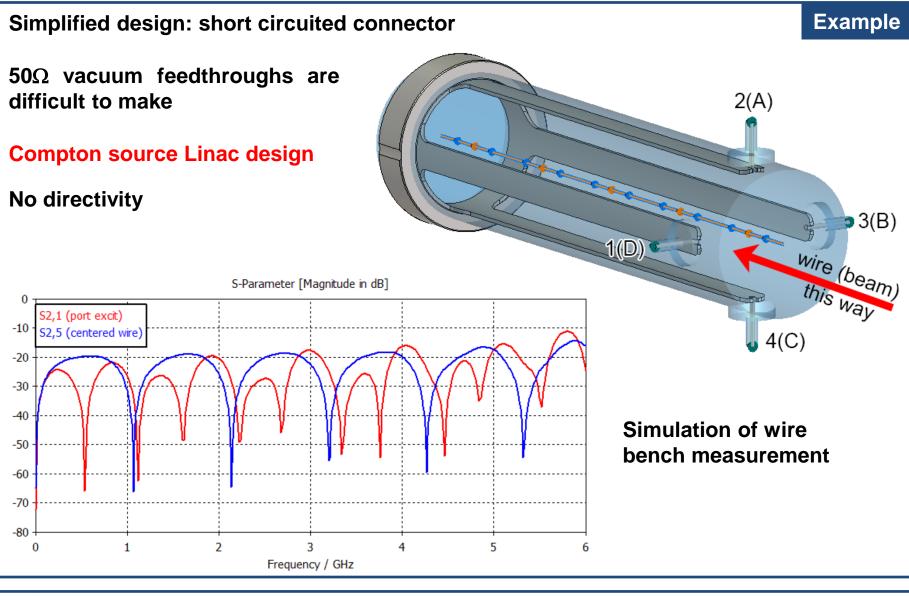
 $Z(\omega) = j\phi Z_0 e^{j\frac{\pi}{2}} e^{-j\omega\frac{\ell}{c}} \sin\left(\omega\frac{\ell}{c}\right)$

Courtesy of M. Wendt



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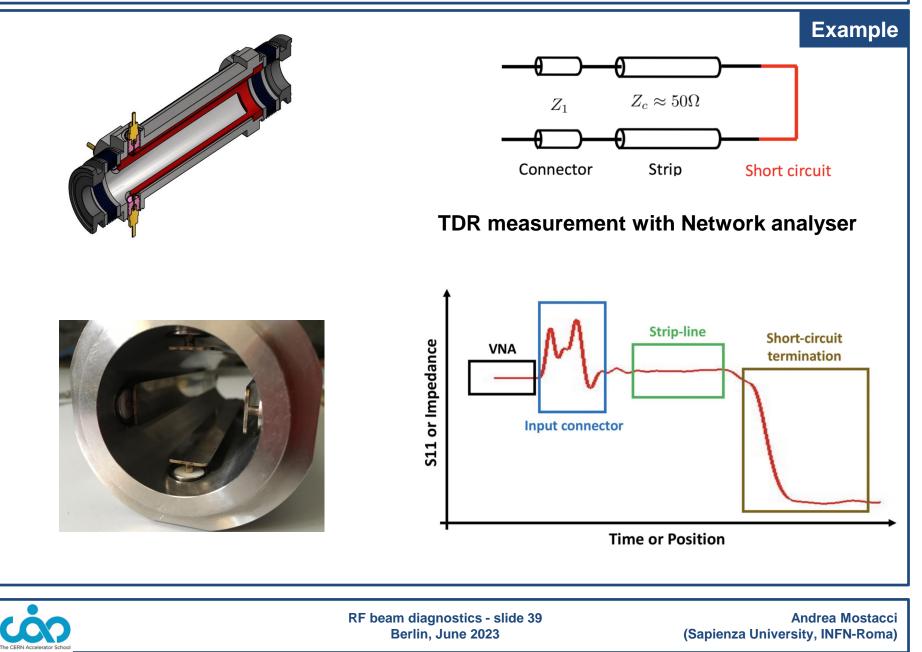
SHORT CIRCUITED STRIPLINE



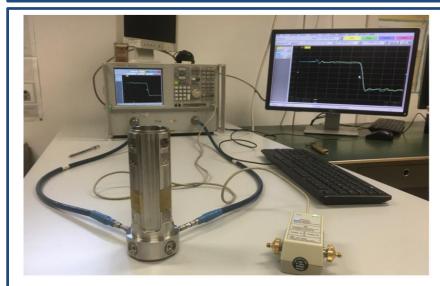


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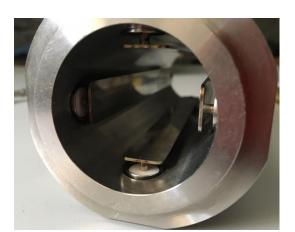
SHORT CIRCUITED STIPLINE BPM

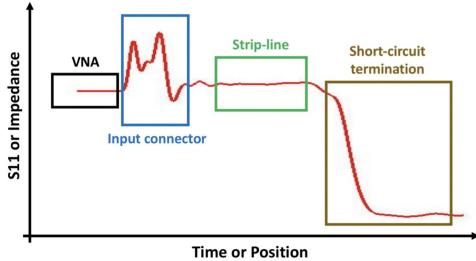


SHORT CIRCUITED STIPLINE BPM



TDR measurement with Network analyser



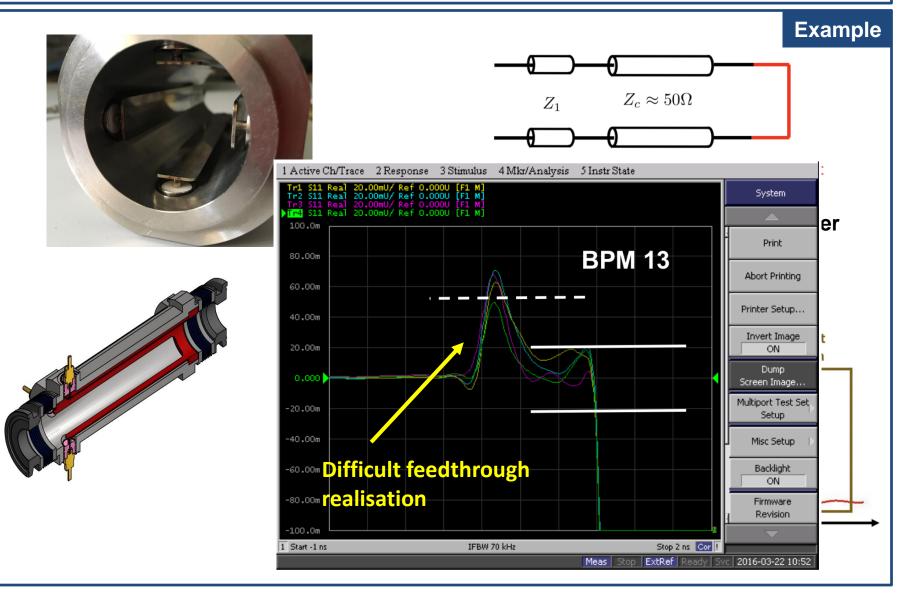




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Example

ACCEPTANCE TEST OF BPM



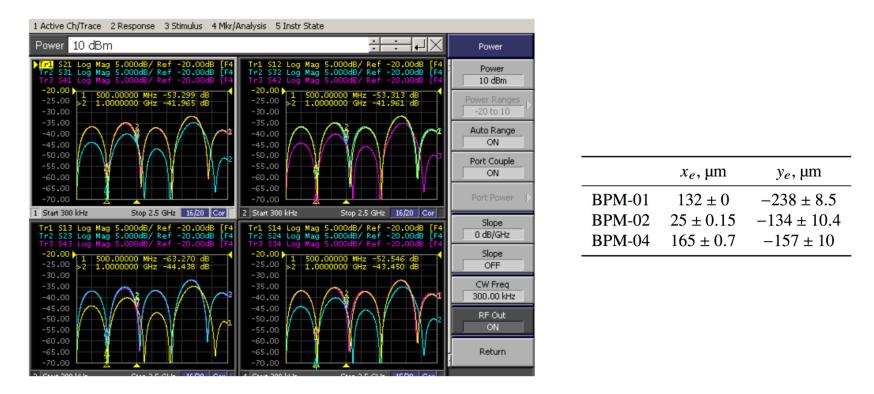


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OFFSET CALIBRATION

Accuracy

Lambertson method uses the coupling between strips to determine the gain factors of each electrode; the ratios between gain factors then provide the difference between the mechanical and electrical centres.

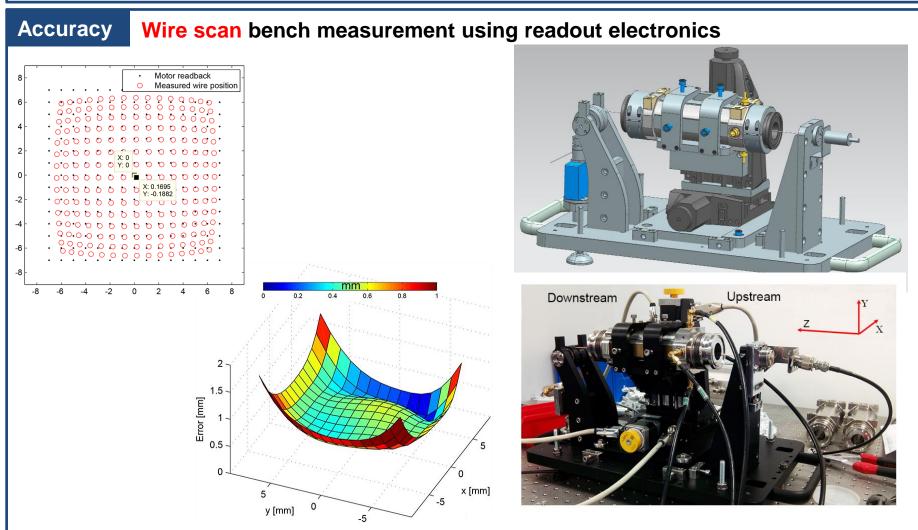


A. A. Nosych et al., **Measurements and calibration of the stripline BPM for the ELI-NP facility with the stretched wire method**, IBIC2015, Melbourne, Australia.



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NON LINEAR RESPONSE OF BPM

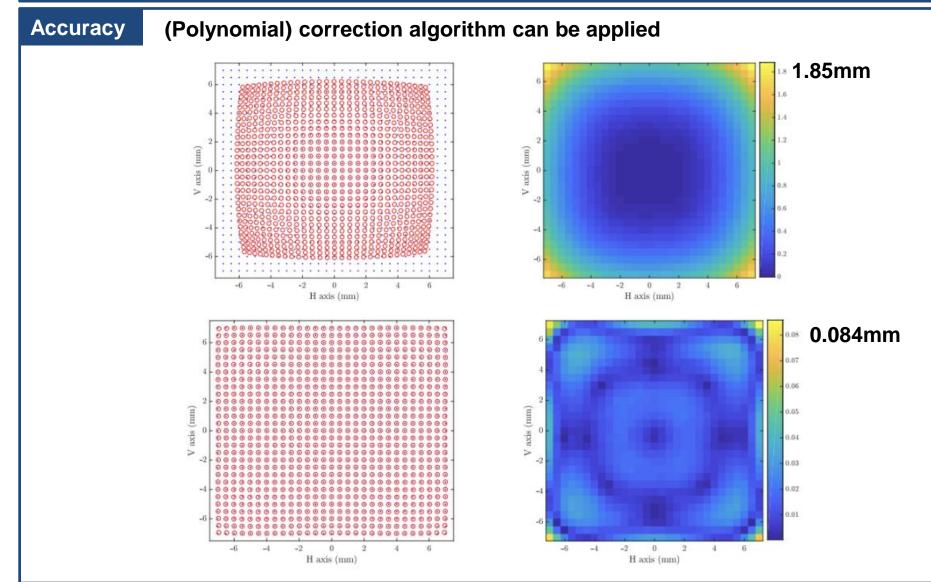


A. A. Nosych et al., **Measurements and calibration of the stripline BPM for the ELI-NP facility with the stretched wire method**, IBIC2015, Melbourne, Australia.



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CORRECTION OF NON LINEAR RESPONSE

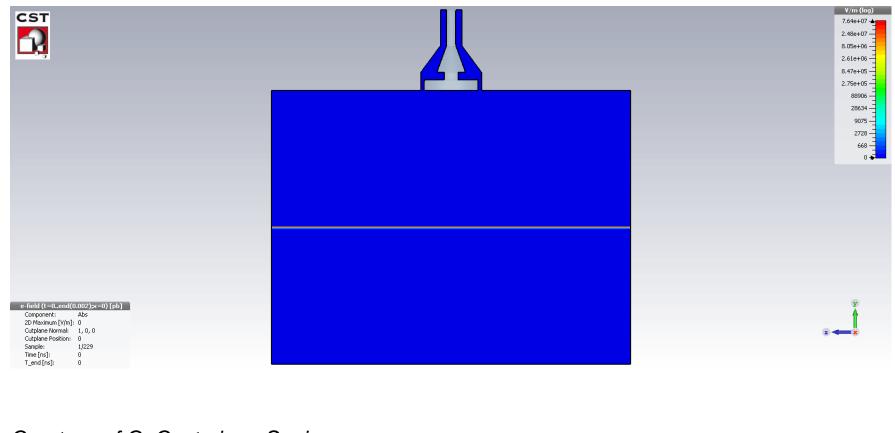




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WAKE FIELDS IN BPMs

Maybe relevant for novel low emittance rings ...



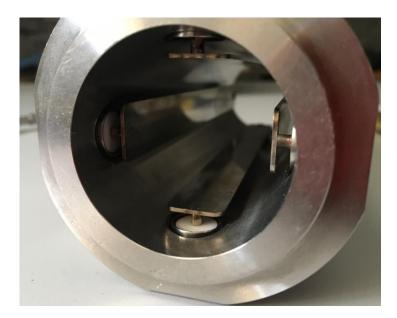
Courtesy of G. Castorina - Sapienza



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TRANSVERSE POSITION MEASUREMENT

Strip line BPM



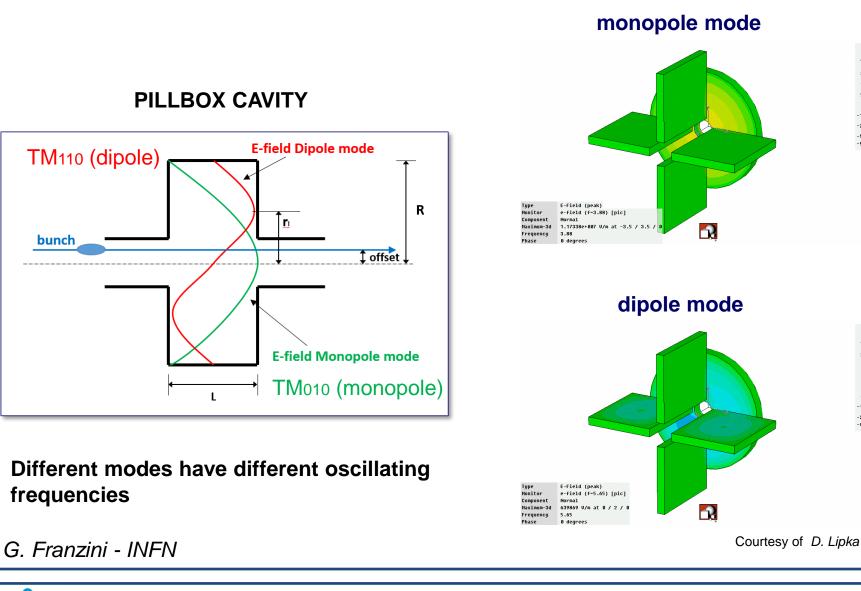
Cavity BPM





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FIELD EXCITED BY A OFFSET BUNCH IN CAVITY





RF beam diagnostics - slide 47 Berlin, June 2023 Andrea Mostacci (Sapienza University, INFN-Roma)

U/m 9.34e6 3.92e6 1.73e6

5.30e5 -1.04e6 -2.66e6 -5.62e6

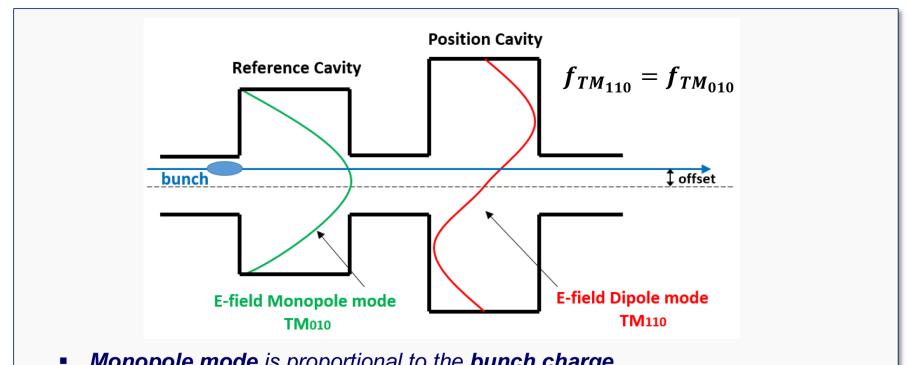
-9.34e6

U/m 4.76e5

2.00e5 88206 26994

-53847 -1.36e5 -2.86e5 -4.76e5

CAVITY BPM - TWO PILLBOX RESONATORS



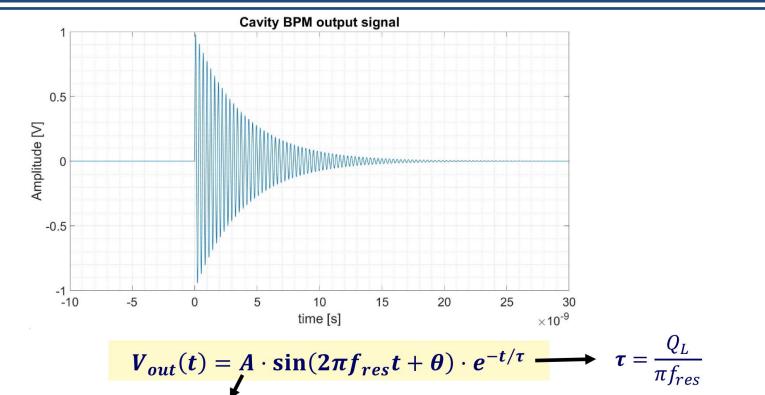
- *Monopole mode* is proportional to the **bunch charge**.
- **Dipole mode** is proportional to the **bunch charge and bunch offset**.

Extracting Dipole and Monopole mode signals is possible to measure the beam offset independently by the beam charge as well as offset sign. The working frequency is driven by the electronics.

G. Franzini - INFN



CAVITY BPM OUTPUT SIGNALS



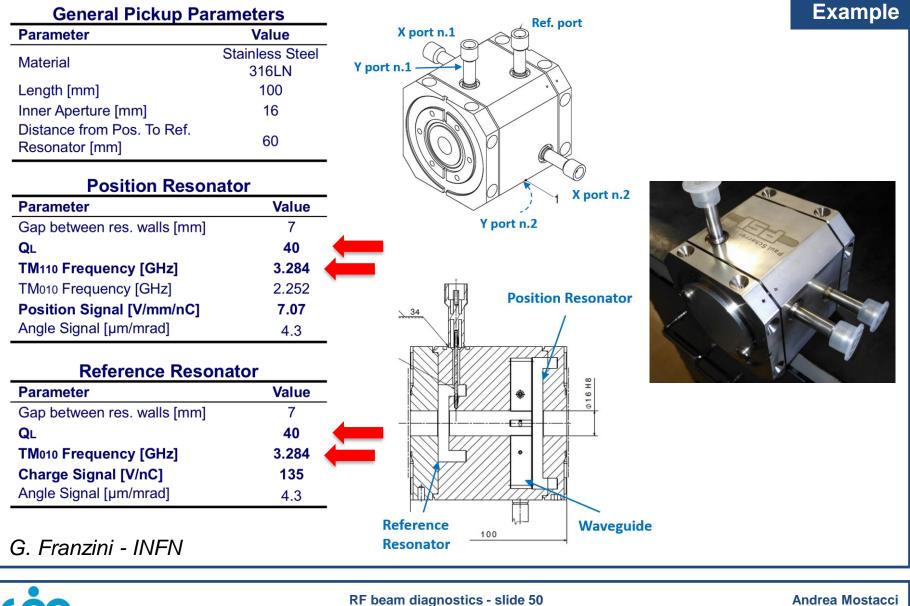
A is proportional to beam charge for TM010 and proportional to charge and beam offset for TM110.

- The two cavities are designed to produce signals with the same frequency and decay constant (τ) respectively for monopole and dipole mode.
- Three signals per bunch are extracted: horizontal and vertical polarization of the dipole mode (X and Y) and the monopole mode (I).

G. Franzini - INFN



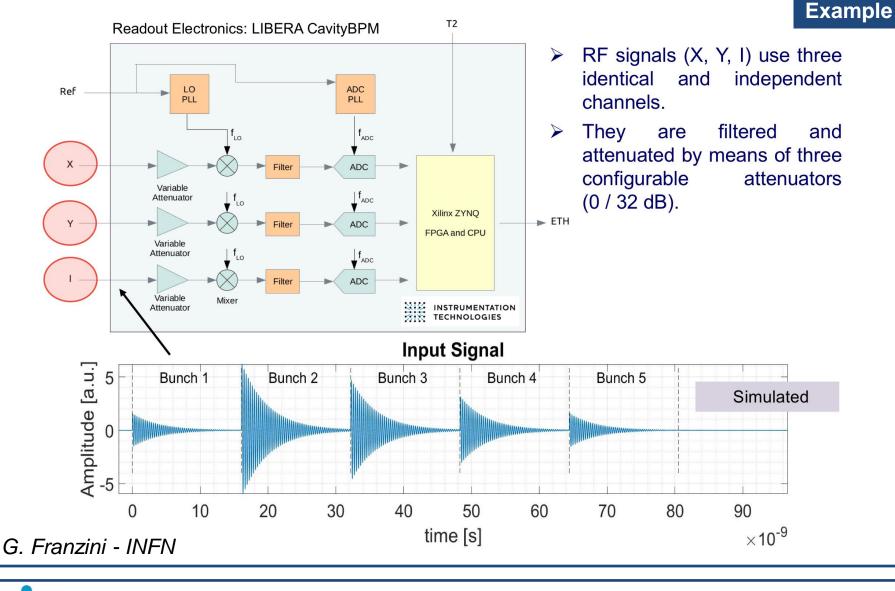
CAVITY BPM FOR MULTIBUNCH OPERATION



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he CERN Accelerator Scho

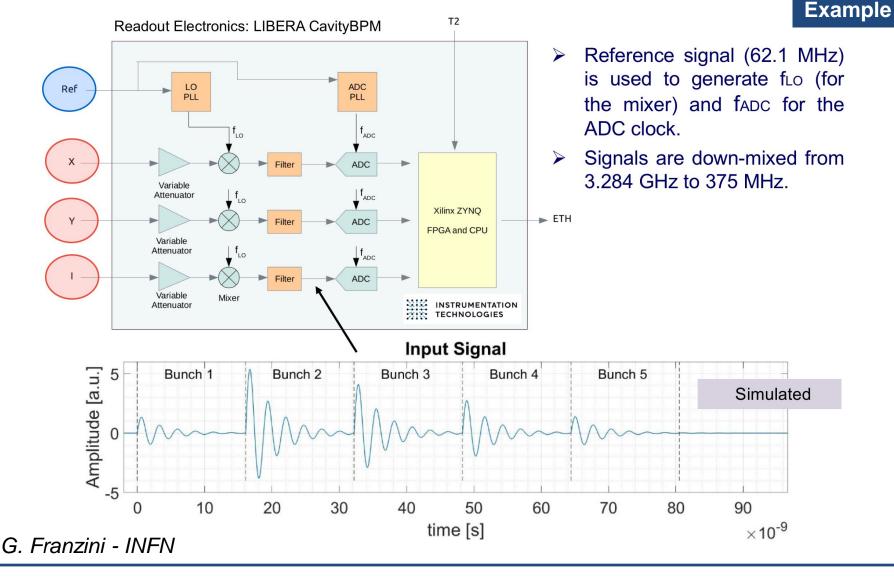
CAVITY BPM - SIGNAL PROCESSING (1/3)





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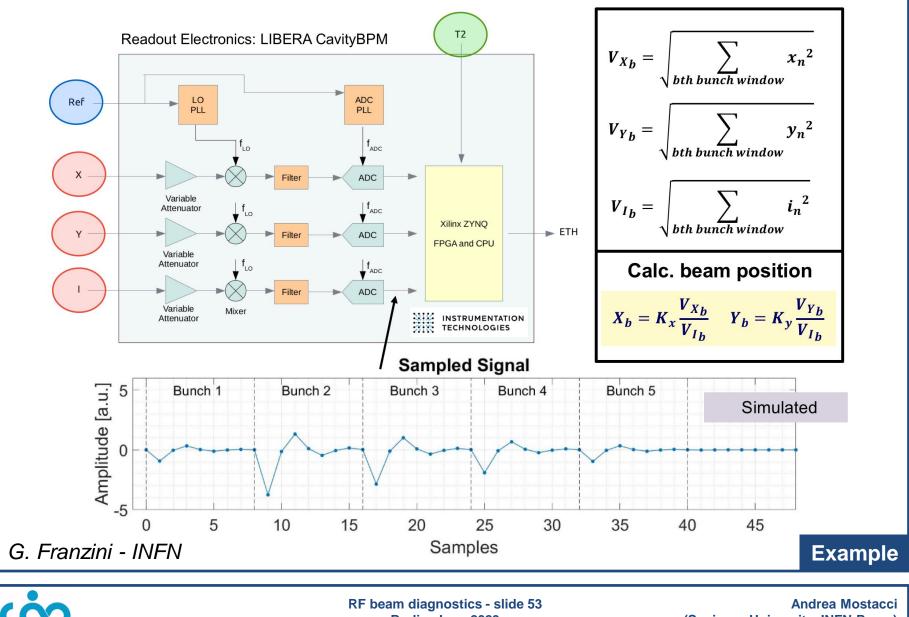
CAVITY BPM - SIGNAL PROCESSING (2/3)





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CAVITY BPM - SIGNAL PROCESSING (3/3)



Berlin, June 2023

The CERN Accelerator School

(Sapienza University, INFN-Roma)

CBPM MEASUREMENTS AT SWISSFEL

CBPM16 CBPM8 Measurement obtained by correlating the reading of three adjacent CBPMs of the same type with similar offset. 100 CBPM8 (High-Q) CBPM16 (Low-Q) **CBPM16** Model Position Resolution [um RMS] 100 mm Length 10 Very good performance Inner 16 mm at low charge. Aperture Typ. Pos. ±5 mm 1 Range **Charge Range** 10-200 pC **Bunch** 28 ns 0.1 Spacing 20 25 0 5 10 15 QL 40 Charge [pC] Frequency 3.2844 GHz 4.9266 GHz

B. Keil et al., First beam commissioning experience with the SwissFEL CAVITY BPM SYSTEM, IBIC2017, Grand Rapids, MI, USA



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CBPM8

100 mm

8 mm

±1 mm

10 ms

1000

10-200 pC

CAVITY BPM IN COMPTON MACHINES

Interaction Point 🔒 👔 🚛		Example
	rity BPM Gamma Beam Specifications	
Cavity BPM	Parameter	Value
	Energy [MeV]	0.2 - 19.5
	Spectral Density [ph/(s⋅eV)]	$0.8 - 4 \cdot 10^4$
	Bandwidth rms [%]	≤ 0.5
	Peak brilliance [Nph/(s·mm²·mrad²·0.1%)]	10 ²⁰ – 10 ²³

By using an optical re-circulator, a single laser pulse will collide with a multi-bunch (up to 32) electron beam at the interaction point, generating the gamma beam by Compton back-scattering.

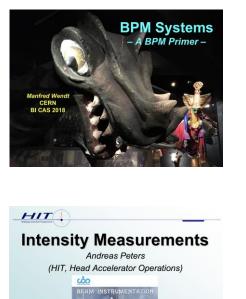
➤ Two Interaction Point modules are foreseen. One at low energy (EeL ≤ 280 MeV), the other at high energy (EeL ≤ 720 MeV).

G. Franzini - INFN



REFERENCES

Beam Instrumentation CAS 2018

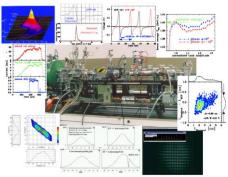


A beam instrumentation primer

Lecture Notes on Beam Instrumentation and Diagnostics

> Peter Forck Gesellschaft für Schwerionenforschung (GSI) Darmstadt, Germany e-mail: p.forck@gsi.de Joint University Accelerator School January – March 2020





A picture of the mobile test bench including some measurements, as provided for the commissioning of the high current injector at GSI in 1999.

Bergoz Instruments manual – www.bergoz.com

P. Nenzi, et al. Development of a Passive Cavity Beam Intensity Monitor for Pulsed Proton Beams for Medical Applications, IBIC'19, 9 September 2019, Malmö, Sweden



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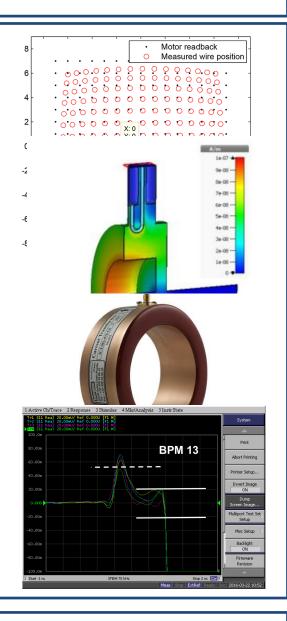
CONCLUSION

Accuracy and calibration procedures

Primer of cavity based beam measurement

Example of industrially available diagnostics

Use of **bench measurement** in diagnostics set-up





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